

Title (en)

PROBE CARD FOR AN APPARATUS FOR TESTING ELECTRONIC DEVICES

Title (de)

SONDENKARTE FÜR EINE VORRICHTUNG ZUM TESTEN ELEKTRONISCHER VORRICHTUNGEN

Title (fr)

CARTE SONDE POUR APPAREIL D'ESSAI DE DISPOSITIFS ÉLECTRONIQUES

Publication

**EP 2859361 B1 20190731 (EN)**

Application

**EP 13734651 A 20130607**

Priority

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- EP 2013001675 W 20130607

Abstract (en)

[origin: WO2013182317A1] Herein described is a probe card for an apparatus for testing electronic devices, of the type comprising at least one probe head (21) which houses a plurality of contact probes (22), each contact probe (22) having at least one contact tip suitable to abut against contact pads of a device to be tested, as well as a supporting plate (23) of such probe head (21) associated with a stiffener (24, 24') via an interface plate (25). Suitably, the probe card (20) comprises a plurality of connecting elements (27) with clearance between the supporting plate (23) and the interface plate (25) housed in a floating manner in a plurality of respective seats (28) made in the supporting plate (23) and a plurality of further connecting elements (27') without clearance between the interface plate (25) and the stiffener (24).

IPC 8 full level

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CPC (source: EP KR US)

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